

J.C. PATENTS

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CERTIFICATE OF TRANSMISSION

November 5, 2004

Atty Docket No.	:	JCLA7737-R
Appl. No.	:	10/015,414
Filing Date	:	December, 12, 2001
Pages	:	Cover + 2

BY FACSIMILE ONLY

Fax No.	;	703-746-4000	
Attention	:	BOX ISSUE FEE Commissioner for Patents	
From	;	Jiawei Huang, Reg. No. 43,330	
MESSAGE	:	Enclosed herewith are: [x] Issue Fee Transmittal Sheet. [x] Comments on Statement of Reasons for Allowance.	

Sir:

I hereby certify that this correspondence is being facsimile transmitted to the Patent and Trademark Office on November 5, 2004 at the above indicated fax number.

Sign by: Michelle Chang

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TRADEN

PATENT Docket No. JCLA7737-R US App. No. 10/015,414

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In reapplication of: : TSO-HUNG FAN et al.

Application No.: : 10/015,414

Filed: : December 12, 2001)

For: : METHOD FOR PROGRAMMING AND)

ERASING NON-VOLATILE MEMORY WITH NITRIDE TUNNELING LAYER

COMMENTS ON STATEMENT OF REASONS FOR ALLOWANCE

Mail Stop Issue Fee

Commissioner for Patents P.O. Box 1450

Alexandria, VA 22313-1450

Dear Sir:

Applicant respectfully submits the following comments on Examiner's statement of reasons for allowance.

In the Notice of Allowability mailed September 20, 2004, the Examiner stated that "the prior art did not teach the method above further applied in non-volatile memory cell being provided with a nitride tunneling layer disposed on the substrate, without a dielectric layer therebetween, ...". Applicant would like to point out that, in the allowed claims 5-7 and 9-11, there is no such limitation as "without a dielectric layer therebetween" (between the substrate and the nitride tunneling layer) being recited.

Date: 11 / 5 / 2004

4 Venture, Suite250 Irvine, CA 92618 Tel.: (949) 660-0761 Respectively submitted

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